

Notice of References Cited

Application/Control No.

10/594,065

Applicant(s)/Patent Under
Reexamination
TAKEUCHI ET AL.

Examiner

VERNON P. WEBB

Art Unit

2811

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0121693 A1	06-2005	Udagawa et al.	257/190
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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